

**Search Notes**

Application/Control No.

08/917,480

Examiner

Tien Dinh

Applicant(s)/Patent under  
Reexamination

WAKAYAMA, SEAN R.

Art Unit

3644

**SEARCHED**

Class	Subclass	Date	Examiner
Updated		6/16/2008	TD
244	215, 213		
	199, 136		
	75R		
	203	8/1/1998	TD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same		6/17/2008	TD

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR